S	earch Notes	

Application/Control No.
10/642,477
Examiner

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/642,477	KAWAI ET AL.	
Examiner	Art Unit	
Jeffrey G. Hoekstra	3736	

SEARCHED				
	SEARONED			
Class	Subclass	Date	Examiner	
600	587	1/11/2006	JGH	
600	595	1/11/2006	JGH	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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